	Type	Hits	Search Text	DBs	Time Stamp	Comments	Error Definition
1	BRS	1568	382/130,131,132,238,300.ccls.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/14 15:34		
2	BRS	890	702/23,32,33,40,179.ccls.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/14 15:54		
3	IS&R	0	("6868967").PN.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/13 15:26		
4	IS&R	0	("6768967").PN.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/13 15:27		
5	BRS	3	"20020038196"	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/13 15:27		
6	BRS	2	"20020038196"	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/15 16:08		

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	Type	Hits	Search Text	DBs	Time Stamp	Comments	Error Definition
7	BRS	1	measur$3 with parameter$1 with sample$1 with diffractive adj structure$1	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/13 15:41		
8	BRS	3	measur$3 with parameter$1 with sample$1 and diffractive adj structure$1	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/13 15:42		
9	BRS	89	measur$3 with parameter$1 with sample$1 and diffract$3 with structure$1	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/13 15:43		
10	BRS	8	measur$3 with parameter$1 with (semiconductor$1 or IC$1 or (integrated adj circuit$1) or wafer$1) with sample$1 and diffract$3 with structure$1	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/13 15:58		
11	BRS	26	parameter$1 with (semiconductor$1 or IC$1 or (integrated adj circuit$1) or wafer$1) with sample$1 and diffract$3 with structure$1	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/13 16:33		

	Type	Hits	Search Text	DBs	Time Stamp	Comments	Error Definition
12	BRS	1	parameter$1 with (semiconductor$1 or IC$1 or (integrated adj circuit$1) or wafer$1) with sample$1 and diffract$3 with structure$1 and database with interpolat$3	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/13 15:59		
13	BRS	6	diffract$3 with structure$1 and database with interpolat$3	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/13 16:03		
14	BRS	6	diffract$3 with structur$3 and database with interpolat$3	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/13 16:09		
15	BRS	7	diffract$3 with (microstruct$3 or structur$3) and database with interpolat$3	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/13 16:06		
16	BRS	0	diffract$3 with structur$3 and database with interpolat$3 with iterative$2	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/13 16:07		

	Type	Hits	Search Text	DBs	Time Stamp	Comments	Error Definiti on
17	BRS	0	database with interpolat$3 with iterative$2	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/13 16:07		
18	BRS	30	database and interpolat$3 with iterative$2	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/13 16:12		
19	BRS	1	optical and diffract$3 and database and interpolat$3 with iterative$2	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/13 16:08		
20	BRS	2	diffract$3 and database and interpolat$3 with iterative$2	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/13 16:08		
21	BRS	371	database with interpolat$3	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/13 16:13		
22	BRS	20	database with interpolat$3 with model$1	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/13 16:13		

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	Type	Hits	Search Text	DBs	Time Stamp	Comments	Error Definiti on
23	BRS	0	database with interpolat$3 with actual with optical	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/13 16:14		
24	BRS	10	database with interpolat$3 with optical	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/13 16:15		
25	BRS	6	database with interpolat$3 with optical with (scatter$3 or diffract$3)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/13 16:19		
26	IS&R	2	("6476920").PN.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/13 16:19		
27	BRS	1	measur$5 with parameter$1 with (semiconductor$1 or IC$1 or (integrated adj circuit$1) or wafer$1) and (database-search$3 or database adj search$3) with interpolat$3	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/13 16:35		
28	BRS	179	measur$5 with parameter$1 with (semiconductor$1 or IC$1 or (integrated adj circuit$1) or wafer$1) and interpolat$3	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/13 16:36		

	Type	Hits	Search Text	DBs	Time Stamp	Comments	Error Definiti on
29	BRS	42	measur$5 with parameter$1 with (semiconductor$1 or IC$1 or (integrated adj circuit$1) or wafer$1) and interpolat$3 with parameter$1	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/13 16:37		
30	BRS	8	measur$5 with parameter$1 with (semiconductor$1 or IC$1 or (integrated adj circuit$1) or wafer$1) and interpolat$3 with parameter$1 and theoretical	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/13 16:41		
31	BRS	7	(semiconductor$1 or IC$1 or (integrated adj circuit$1) or wafer$1) and interpolat$3 with parameter$1 and theoretical with empirical	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/13 16:44		
32	BRS	24	(semiconductor$1 or IC$1 or (integrated adj circuit$1) or wafer$1) and interpolat$3 with parameter$1 and theoretical and empirical	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/13 16:45		

	Type	Hits	Search Text	DBs	Time Stamp	Comments	Error Definition
33	BRS	8	(semiconductor$1 or IC$1 or (integrated adj circuit$1) or wafer$1) and interpolat$3 with parameter$1 and theoretical and empirical and (scatter$3 or diffract$3)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/13 16:46		
34	BRS	20	(semiconductor$1 or IC$1 or (integrated adj circuit$1) or wafer$1) and interpolat$3 with parameter$1 and theoretical and (scatter$3 or diffract$3)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/14 15:18		
35	BRS	2	(semiconductor$1 or IC$1 or (integrated adj circuit$1) or wafer$1) and interpolat$3 with parameter$1 with optical and theoretical and (scatter$3 or diffract$3)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/13 16:49		
36	BRS	14	evaluat$3 with parameter$1 with (scater$3 or diffract$3) and (IC$1 or (integrated adj circuit$1) or semiconductor$1 or wafer$1)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/13 16:51		

	Type	Hits	Search Text	DBs	Time Stamp	Comments	Error Definition
37	BRS	3	evaluat$3 with parameter$1 with (scater$3 or diffract$3) and (IC$1 or (integrated adj circuit$1) or semiconductor$1 or wafer$1) and interpolat$3	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/13 16:51		
38	BRS	162	(semiconductor$1 or IC$1 or (integrated adj circuit$1) or wafer$1) and interpolat$3 and theoretical with measured	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/14 15:19		
39	BRS	9	(semiconductor$1 or IC$1 or (integrated adj circuit$1) or wafer$1) and interpolat$3 with optical$2 and theoretical with measured	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/14 15:20		
40	BRS	39	(semiconductor$1 or IC$1 or (integrated adj circuit$1) or wafer$1) and interpolat$3 and optical$2 with wavelength$1 and theoretical with measured	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/15 13:22		
41	BRS	6377	356/601-625,635-640,237.1, 237.2.ccls.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/14 15:32		

	Type	Hits	Search Text	DBs	Time Stamp	Comments	Error Definition
42	BRS	2001	382/130,131,132,238,300.ccls.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/14 15:34		
43	BRS	1151	702/23,32,33,40,179.ccls.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/14 15:54		
44	BRS	2593	702/23,32,33,40,179,34,35, for.134,for.135,for.137,for.139,for.156,for.ccls.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/14 15:55		
45	BRS	95	250/341.4.ccls.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/14 16:02		
46	BRS	3	250/341.4.ccls. and interpolat$3	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/14 16:02		
47	BRS	41	4555767.uref.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/14 16:03		

	Type	Hits	Search Text	DBs	Time Stamp	Comments	Error Definiti on
48	BRS	6	4555767.uref. and interpolat$3	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/15 09:32		
49	BRS	139	diffract$3 with structure$1 and optical with characteristics with parameter$1	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/15 09:33		
50	BRS	0	diffract$3 with structure$1 and evaluat$3 with optical with characteristics with parameter$1	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/15 09:33		
51	BRS	5	diffract$3 with structure$1 and optical with characteristics with parameter$1 and interpolat$3	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/15 09:34		
52	BRS	4	diffract$3 with structure$1 and optical with selected with parameter$1 and interpolat$3	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/15 09:35		
53	BRS	76	diffract$3 with structure$1 and optical with parameter$1 and interpolat$3	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/15 09:36		

	Type	Hits	Search Text	DBs	Time Stamp	Comments	Error Definition
54	BRS	44	diffract$3 with structure$1 and optical with parameter$1 and interpolat$3 and fitting	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/15 09:40		
55	BRS	25	diffract$3 with structure$1 and optical with parameter$1 and interpolat$3 and (repeat$4 or iterat$5) with fitting	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/15 09:37		
56	BRS	0	diffract$3 with structure$1 and optical with parameter$1 and interpolat$3 and fitting not (diffract$3 with structure$1 and optical with parameter$1 and interpolat$3 and fitting)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/15 09:40		
57	BRS	44	diffract$3 with structure$1 and optical with parameter$1 and interpolat$3 and fitting not "10"	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/15 11:19		
58	BRS	19	diffract$3 with structure$1 and optical with parameter$1 and interpolat$3 and fitting not (diffract$3 with structure$1 and optical with parameter$1 and interpolat$3 and (repeat$4 or iterat$5) with fitting)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/15 11:32		

	Type	Hits	Search Text	DBs	Time Stamp	Comments	Error Definition
59	BRS	6721	438/5-7,14-18,907.ccls.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/15 11:25		
60	BRS	19	diffract$3 with structure$1 and optical with parameter$1 and interpolat$3 and fitting not (diffract$3 with structure$1 and optical with parameter$1 and (extrapolation or interpolat$3) and (repeat$4 or iterat$5) with fitting)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/15 10:24		
61	BRS	19	diffract$3 with structure$1 and optical with parameter$1 and interpolat$3 and fitting not (diffract$3 with structure$1 and optical with parameter$1 and (extrapolat$3 or interpolat$3) and (repeat$4 or iterat$5) with fitting)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/15 10:25		

	Type	Hits	Search Text	DBs	Time Stamp	Comments	Error Definition
62	BRS	3	diffract$3 with structure$1 and optical with parameter$1 and (extrapolat$3 or interpolat$3) with model$3 and fitting	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/15 10:26		
63	BRS	2	diffract$3 with structure$1 and optical with parameter$1 and (extrapolat$3 or interpolat$3) with model$3 with theoretical and fitting	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/15 10:26		
64	BRS	2	diffract$3 with structure$1 and optical with parameter$1 and (extrapolat$3 or interpolat$3) with theoretical and fitting	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/15 10:27		
65	BRS	2	diffract$3 and structure$1 and optical with parameter$1 and (extrapolat$3 or interpolat$3) with theoretical and fitting	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/15 10:27		
66	BRS	2	diffract$3 and optical with parameter$1 and (extrapolat$3 or interpolat$3) with theoretical and fitting	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/15 10:27		

	Type	Hits	Search Text	DBs	Time Stamp	Comments	Error Definition
67	BRS	4	optical with parameter$1 and (extrapolat$3 or interpolat$3) with theoretical and fitting	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/15 10:34		
68	BRS	21	optical with parameter$1 and (extrapolat$3 or interpolat$3) with model$3 and fitting	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/15 10:35		
69	BRS	0	evaluat$3 with diffract$3 and optical with parameter$1 and (extrapolat$3 or interpolat$3) with model$3 and fitting	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/15 10:35		
70	BRS	0	evaluat$3 with optical with parameter$1 and (extrapolat$3 or interpolat$3) with model$3 and fitting	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/15 10:36		
71	BRS	66	evaluat$3 with parameter$1 and (extrapolat$3 or interpolat$3) with model$3 and fitting and optical$2	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/15 10:36		

	Type	Hits	Search Text	DBs	Time Stamp	Comments	Error Definiti on
72	BRS	2	evaluat$3 with parameter$1 and (extrapolat$3 or interpolat$3) with model$3 and fitting and measur$5 with optical$2 with sample$1	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/15 10:39		
73	BRS	6	evaluat$3 with parameter$1 and (extrapolat$3 or interpolat$3) with model$3 and fitting with measur$5 with optical$2	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/15 10:40		
74	BRS	22	evaluat$3 with parameter$1 and interpolat$3 with fitting and measur$5 with optical$2	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/15 10:44		
75	BRS	23	parameter$1 with equal$1 with interpolat$3 with point$1	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/15 10:47		
76	BRS	0	evaluat$3 with parameter$1 with equal$1 with interpolat$3 with point$1	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/15 10:46		

	Type	Hits	Search Text	DBs	Time Stamp	Comments	Error Definition
77	BRS	1	(semiconductor$1 or IC$1 or (integrated adj circuit$1) or wafer$1) and parameter$1 with equal$1 with interpolat$3 with point$1	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/15 10:48		
78	BRS	158	(semiconductor$1 or IC$1 or (integrated adj circuit$1) or wafer$1) and parameter$1 with interpolat$3 with point$1	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/15 10:48		
79	BRS	197	(semiconductor$1 or IC$1 or (integrated adj circuit$1) or wafer$1) and parameter$1 with interpolat$3 with (model$3 or point$1)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/15 10:52		
80	BRS	14	(semiconductor$1 or IC$1 or (integrated adj circuit$1) or wafer$1) and evaluat$3 with parameter$1 with interpolat$3 with (model$3 or point$1)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/15 12:26		
81	BRS	3	438/$.ccls. and (semiconductor$1 or IC$1 or (integrated adj circuit$1) or wafer$1) and parameter$1 with interpolat$3 with (model$3 or point$1)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/15 10:49		

	Type	Hits	Search Text	DBs	Time Stamp	Comments	Error Definition
82	BRS	4	(semiconductor$1 or IC$1 or (integrated adj circuit$1) or wafer$1) and parameter$1 with interpolat$3 with (model$3 or point$1) and diffract$3 with structure$1	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/15 10:52		
83	BRS	11	(semiconductor$1 or IC$1 or (integrated adj circuit$1) or wafer$1) and parameter$1 with interpolat$3 with (model$3 or point$1) and diffract$3	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/15 10:53		
84	BRS	0	438/.7.ccls. and interpolat$3	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/15 11:01		
85	BRS	0	438/.$.ccls. and interpolat$3	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/15 11:01		
86	BRS	13	438/7.ccls. and interpolat$3	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/15 11:45		

	Type	Hits	Search Text	DBs	Time Stamp	Comments	Error Definition
87	BRS	1	438/$.ccls. and evaluat$3 with parameter$1 with interpolat$3	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/15 11:05		
88	BRS	21	438/$.ccls. and parameter$1 with interpolat$3	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/15 11:04		
89	BRS	125	evaluat$3 with parameter$1 with interpolat$3	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/15 11:05		
90	BRS	0	evaluat$3 with parameter$1 with interpolat$3 with fitting	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/15 11:06		
91	BRS	9	evaluat$3 with parameter$1 with interpolat$3 and fitting	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/15 11:06		
92	BRS	12	diffract$3 with structure$1 and parameter$1 and interpolat$3 with model$1	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/15 11:20		

	Type	Hits	Search Text	DBs	Time Stamp	Comments	Error Definition
93	BRS	13	438/5-7,14-18,907.ccls. and parameter$1 with interpolat$3	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/15 11:26		
94	BRS	459	number with interpolat$3 with parameter$1	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/15 11:47		
95	BRS	16	equal with number with interpolat$3 with parameter$1	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/15 11:48		
96	BRS	130	equal with interpolat$3 with parameter$1	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/15 11:57		
97	BRS	0	(438/$.ccls. and 250/$.ccls. and 369/$.ccls.) and equal with interpolat$3 with parameter$1	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/15 11:58		
98	BRS	1	equal with interpolat$3 with parameter$1 and optical with structure$1	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/15 11:57		

	Type	Hits	Search Text	DBs	Time Stamp	Comments	Error Definiti on
99	BRS	12	equal with interpolat$3 with parameter$1 and (semiconductor$1 or wafer$1)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/15 12:07		
100	BRS	0	(438/$.ccls. and 250/$.ccls. and 356/$.ccls.) and equal with interpolat$3 with parameter$1	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/15 11:59		
101	BRS	5	database with interpolat$3 with parameter$1 and (semiconductor$1 or wafer$1)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/15 12:07		
102	IS&R	2	("4999508").PN.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/15 12:26		
103	BRS	5	defin$4 with theoretical with model and (semiconductor$1 or wafer$1) and optical with parameter$1	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/15 12:32		
104	BRS	188	theoretical with model and (semiconductor$1 or wafer$1) and optical with parameter$1	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/15 12:32		

	Type	Hits	Search Text	DBs	Time Stamp	Comments	Error Definition
105	BRS	39	theoretical with model and (semiconductor$1 or wafer$1) and optical with parameter$1 and interpolat$3	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/15 13:13		
106	BRS	3	(semiconductor$1 or wafer$1) and optical with parameter$1 and interpolat$3 with theoretical and fitting	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/15 13:14		
107	IS&R	2	("6340602").PN.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/15 13:22		
108	BRS	374	interpolat$3 with database	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/15 14:32		
109	BRS	6	438/$.ccls. and interpolat$3 with database	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/15 14:33		
110	BRS	2	interpolat$3 with theoretical with database	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/15 14:34		

	Type	Hits	Search Text	DBs	Time Stamp	Comments	Error Definition
111	BRS	15282	(record$3 or stor$3 or sav$3) with interpolat$3	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/15 14:35		
112	BRS	8	(record$3 or stor$3 or sav$3) with interpolat$3 with optical with parameter$1	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/15 14:36		
113	BRS	98	database with stored with interpolat$3	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/15 14:45		
114	BRS	98	database with stored with interpolat$3	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/15 14:45		
115	IS&R	2	("6476920").PN.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/15 16:08		
116	BRS	0	optical adj parameter$1 with equal with interpolat$3	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/15 16:17		

	Type	Hits	Search Text	DBs	Time Stamp	Comments	Error Definiti on
117	BRS	1	optical with parameter$1 with equal with interpolat$3	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/15 16:17		
118	BRS	130	equal with interpolat$3 with parameter$1	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/15 16:18		
119	BRS	8	equal with interpolat$3 with parameter$1 with sample$1	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/07/15 16:18		